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IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Appl. No. : 10/815,671  
Applicant : Alan S. McNULTY  
Filed : April 2, 2004  
TC/A.U. : 2858  
Examiner :  
  
Docket No. : 1936-117  
Customer No. : 06449  
Confirmation No. : 9756

**INFORMATION DISCLOSURE STATEMENT**

Director of the United States Patent  
and Trademark Office  
P.O. Box 1450  
Alexandria, Virginia 22313-1450

Dear Sir:

The material listed on the accompanying forms PTO-1449 and PTO-892, from the parent application having U.S. Serial Number 10/266,621, is cited in compliance with the provisions of 37 C.F.R. §§ 1.56, 1.97 and 1.98. Applicant respectfully requests that the Examiner consider these references with respect to the present application. Copies of these references can be found with the parent application and, accordingly, will not be resubmitted unless requested by the Examiner.

Respectfully submitted,

ROTHWELL, FIGG, ERNST & MANBECK, p.c.

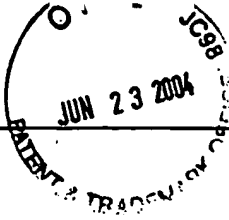
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Serial No. 10/815,671  
Page 2

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# **INFORMATION DISCLOSURE STATEMENT BY APPLICANT**

*Complete if Known*

Application Number	10/815,671
Filing Date	April 2, 2004
First Named Inventor	Alan S. McNulty
Group Art Unit	2858
Examiner Name	Unknown

Sheet	1	of	1	Attorney Docket Number	1936-117
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## **U.S. PATENT DOCUMENTS**

Examiner Initials*	Cite No. <sup>1</sup>	U.S. Patent Document		Name of Patentee or Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY
		Number	Kind Code <sup>2</sup> (if known)		
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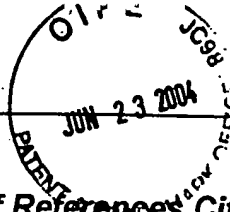
Examiner Initials*	Cite No. <sup>1</sup>	Foreign Patent Document			Name of Patentee of Applicant of Cited Document	Date of Publication of Cited Document MM-DD-YYYY	T <sup>6</sup>
		Office <sup>3</sup> Code	Number <sup>4</sup>	Kind <sup>5</sup> (if known)			

Examiner  
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Date  
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

<sup>1</sup>Unique citation designation number. <sup>2</sup>See attached Kinds of U.S. Patent Documents. <sup>3</sup>Enter Office that issued the document, by the two-letter code. <sup>4</sup>For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. <sup>5</sup>Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. <sup>6</sup>Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.



For S.N. 10/815,671

**Notice of References Cited**

Application/Control No.

10/266,621

Applicant(s)/Patent Under  
Reexamination  
MCNULTY, ALAN S.

Examiner

Anthony T. Dougherty

Art Unit

2863

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	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
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	O					
	P					
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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